## **Power MOSFET**

# 30 V, 52 A, Single N-Channel, μ8FL

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

### **Applications**

- DC-DC Converters
- Power Load Switch
- Notebook Battery Management

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V <sub>DSS</sub>	30	V		
Gate-to-Source Voltage	$V_{GS}$	±20	V		
Continuous Drain		T <sub>A</sub> = 25°C	Ι <sub>D</sub>	15	Α
Current R <sub>θJA</sub> (Note 1)	T <sub>A</sub> = 85°C		1	10.8	
Power Dissipation $R_{\theta JA}$ (Note 1)	$R_{\theta JA}$ $T_A = 25^{\circ}C$		P <sub>D</sub>	2.13	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	21	Α
Current R <sub>θJA</sub> ≤ 10 s (Note 1)		T <sub>A</sub> = 85°C		15	
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	4.2	W
Continuous Drain	State	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	9.3	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C		6.7	
Power Dissipation R <sub>0JA</sub> (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.82	W
Continuous Drain		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	52	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		37.5	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	25.5	W
Pulsed Drain Current	$T_A = 25^{\circ}$	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	144	Α
Operating Junction and S	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		
Source Current (Body Did	I <sub>S</sub>	23	Α		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So $(T_J = 25^{\circ}C, V_{GS} = 10 \text{ V}, I_{GS} = 25 \Omega)$ (Note 3)	E <sub>AS</sub>	42	mJ		
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at  $T_J$  = 25°C,  $V_{GS}$  = 10 V,  $I_L$  = 21 A,  $E_{AS}$  = 22 mJ.

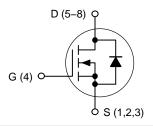


### ON Semiconductor®

### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX		
30 V	5.9 mΩ @ 10 V	52 A		
30 V	9.0 mΩ @ 4.5 V	32 A		

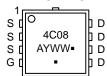
#### **N-Channel MOSFET**





**CASE 511AB** 

### **MARKING DIAGRAM**



4C08 = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>		
NTTFS4C08NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.9	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	58.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	153	C/VV
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{\theta JA}$	30	

- 4. Surface–mounted on FR4 board using 1 sq–in pad, 1 oz Cu.5. Surface–mounted on FR4 board using the minimum recommended pad size.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V	
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	V <sub>GS</sub> = 0 V, I <sub>D(aval)</sub> = 12.6 A, T <sub>case</sub> = 25°C, t <sub>transient</sub> = 100 ns		34			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				13.8		mV/°C	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0		
			T <sub>J</sub> = 125°C			10	μΑ	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	<sub>S</sub> = ±20 V			±100	nA	
ON CHARACTERISTICS (Note 6)								
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.3		2.2	V	
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.0		mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		4.7	5.9		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 18 A		7.2	9.0	mΩ	
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			42		S	
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°C			1.0		Ω	
CHARGES AND CAPACITANCES								
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			1113		pF	
Output Capacitance	C <sub>OSS</sub>				702			
Reverse Transfer Capacitance	C <sub>RSS</sub>				39			
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 1$	5 V, f = 1 MHz		0.035			
Total Gate Charge	Q <sub>G(TOT)</sub>				8.4			
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.8		]	
Gate-to-Source Charge	$Q_GS$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			3.5		nC	
Gate-to-Drain Charge	$Q_{GD}$				3.3		1	
Gate Plateau Voltage	$V_{GP}$				3.4		V	
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			18.2		nC	
SWITCHING CHARACTERISTICS (Note 7)								
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9.0		ns	
Rise Time	t <sub>r</sub>				33			
Turn-Off Delay Time	t <sub>d(OFF)</sub>				15			
Fall Time	t <sub>f</sub>				4.0			

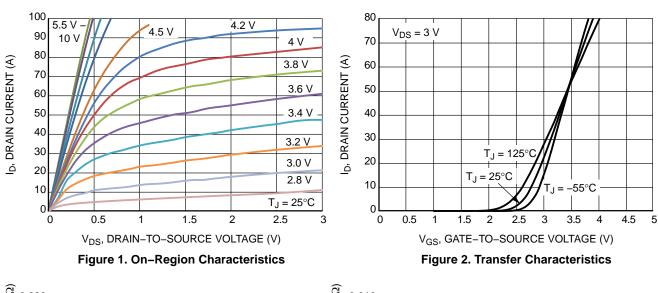
- 6. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .
  7. Switching characteristics are independent of operating junction temperatures.

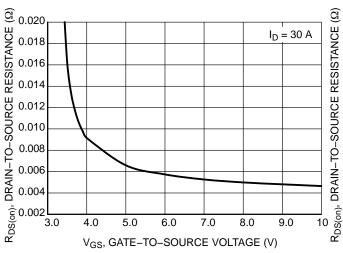
## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N		1001 00110		l	.,,,,	Mux	<b>U</b>
Turn-On Delay Time	t <sub>d(ON)</sub>				7.0		
Rise Time	t <sub>r</sub>	V 40.V.V		26		- ns	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			19		
Fall Time	t <sub>f</sub>				3.0		1
DRAIN-SOURCE DIODE CHARACT	ERISTICS				ı	ı	ı
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.79	1.1	
		$V_{SD}$ $V_{GS} = 0 \text{ V},$ $I_{S} = 10 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$			0.66		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			28.3		
Charge Time	t <sub>a</sub>				14.5		ns
Discharge Time	t <sub>b</sub>				13.8		
Reverse Recovery Charge	$Q_{RR}$			15.3		nC	

<sup>6.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
7. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**





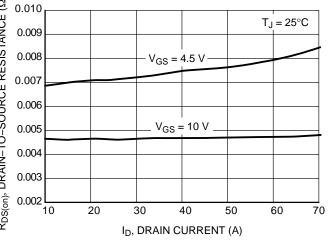
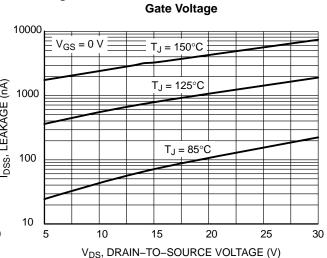


Figure 4. On-Resistance vs. Drain Current and





1.7  $I_{D} = 30 \text{ A}$ 1.6 R<sub>DS(on)</sub>, DRAIN-TO-SOURCE RESISTANCE (NORMALIZED)  $V_{GS} = 10 \text{ V}$ 1.5 DSS, LEAKAGE (nA) 1.4 1.3 1.2 1.1 0.9 0.7 -25 0 25 50 75 100 -50 125 150 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

### **TYPICAL CHARACTERISTICS**

V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

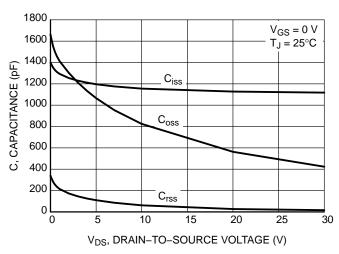


Figure 7. Capacitance Variation

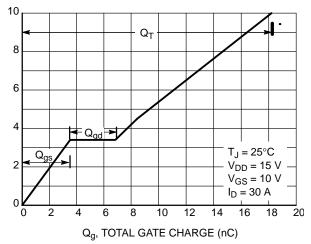


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

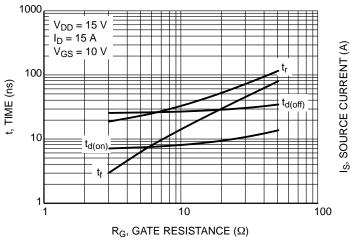


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

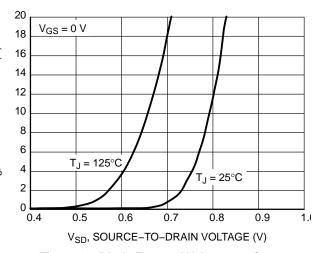


Figure 10. Diode Forward Voltage vs. Current

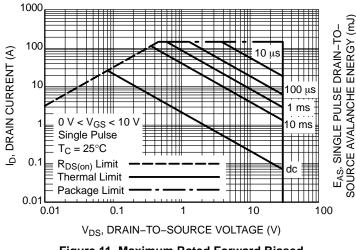


Figure 11. Maximum Rated Forward Biased Safe Operating Area

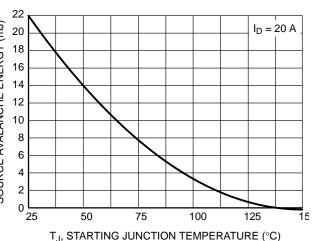


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

### **TYPICAL CHARACTERISTICS**

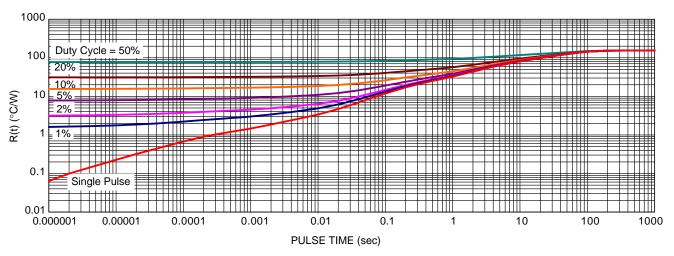


Figure 13. Thermal Response

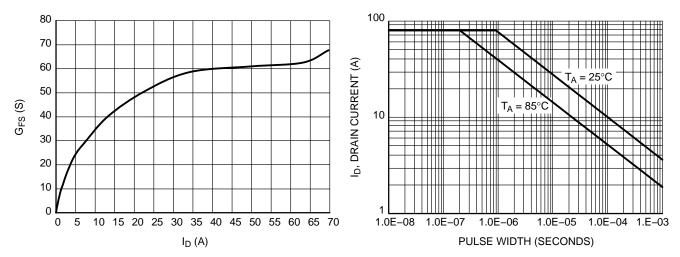
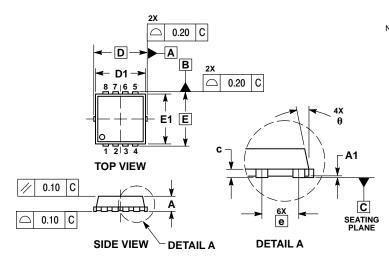


Figure 14. G<sub>FS</sub> vs. I<sub>D</sub>

Figure 15. Avalanche Characteristics

### PACKAGE DIMENSIONS

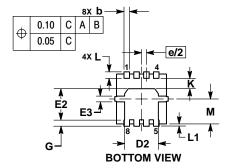
### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



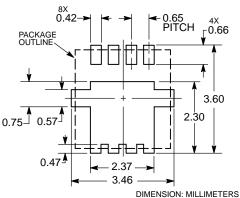
#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	;	3.30 BSC		0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078 0.083		0.088	
E		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	(	3		
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
M	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	



### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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